Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/751,178	LEE ET AL.
Examiner	Art Unit
Ly D. Pham	2827

SEARCHED						
Class	Subclass	Date	Examiner			
365	230.05, 154	2/4/2006	LP			
		<u> </u>				
		<u>.</u>				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			-	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
East (update)		2/4/2006	LP
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